

UNISONIC TECHNOLOGIES CO., LTD

10NM50

Preliminary

10A, 500V N-CHANNEL SUPER-JUNCTION MOSFET

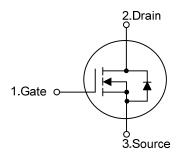
DESCRIPTION

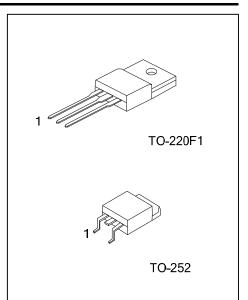
The **UTC 10NM50** is a Super Junction MOSFET Structure and is designed to have better characteristics, such as fast switching time, low gate charge, low on-state resistance and a high rugged avalanche characteristics. This power MOSFET is usually used at DC-DC, AC-DC converters for power applications.

FEATURES

- * $R_{DS(ON)}$ < 0.35 Ω @ V_{GS} =10V, I_D =5.0A
- * By using Super Junction Structure
- * Fast Switching
- * With 100% Avalanche Tested

SYMBOL





ORDERING INFORMATION

Ordering Number		Dookago	Pin Assignment			Dooking
Lead Free	Halogen Free	Package	1 2		3	Packing
10NM50L-TF1-T	10NM50G-TF1-T	TO-220F1	G	D	S	Tube
10NM50L-TN3-R	10NM50L-TN3-R 10NM50G-TN3-R		G	D	S	Tape Reel
Note: Pin Assignment: G: Gate D: Drain S: Source						
10NM50L- <u>TF1-T</u>	(1) T: Tube, R: Tape Reel (2) TF1: TO-220F1, TN3: TO-252					
	(3) L: Lead Free, G: Halogen Free and Lead Free					
MARKING UTC 10NM50 Lot Code	L: Lead Free → G: Halogen Free → Data Code	A BARATA	168	12 8.C	Su	
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■ ABSOLUTE MAXIMUM RATINGS (T_c =25°C, unless otherwise specified)

PARAMETER		SYMBOL	RATINGS	UNIT
Drain-Source Voltage		V _{DSS}	500	V
Gate-Source Voltage		V _{GSS}	±30	V
Drain Current	Continuous	Ι _D	10	А
	Pulsed (Note 2)	I _{DM}	40	А
Avalanche Current (Note 2)		I _{AR}	3.9	А
Avalanche Energy	Single Pulsed (Note 3)	E _{AS}	236	mJ
Peak Diode Recovery dv/dt (Note 4)		dv/dt	6.5	V/ns
Power Dissipation	TO-220F1		48	W
	TO-252	P _D	108	W
Junction Temperature		TJ	150	°C
Storage Temperature Range		T _{STG}	-55 ~ +150	°C

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged. Absolute maximum ratings are stress ratings only and functional device operation is not implied.

2. Repetitive Rating : Pulse width limited by maximum junction temperature.

3. L=31mH, I_{AS} =3.9A, V_{DD} = 50V, R_G =25 Ω , Starting T_J =25°C

4. I_{SD} ≤10A, di/dt ≤200A/µs, V_{DD} ≤BV_{DSS}, Starting T_J=25°C

THERMAL DATA

PARAMETER		SYMBOL	RATING	UNIT	
Junction to Ambient	TO-220F1	θ_{JA}	62.5	°C/W	
	TO-252		110	C/vv	
Junction to Case	TO-220F1	0	2.6	°C/W	
	TO-252	$\theta_{\rm JC}$	1.16	C/W	



■ ELECTRICAL CHARACTERISTICS (T_=25°C, unless otherwise specified)

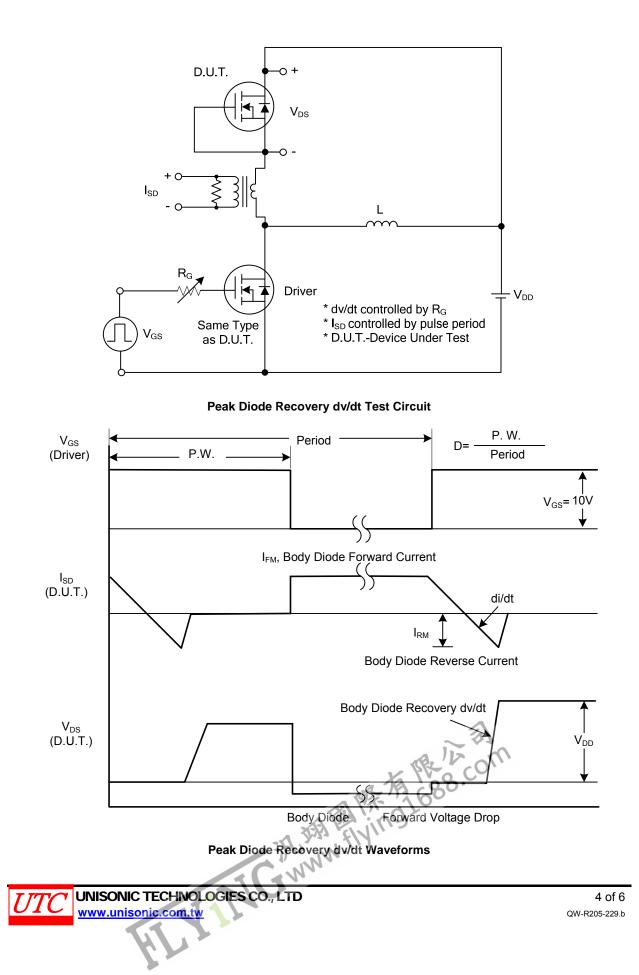
PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT		
OFF CHARACTERISTICS								
Drain-Source Breakdown Voltage	BV _{DSS}	V _{GS} =0V, I _D =250µA	500			V		
Drain-Source Leakage Current	I _{DSS}	I_{DSS} V_{DS} =500V, V_{GS} =0V			10	μA		
Gate-Source Leakage Current	I _{GSS}	$V_{DS}=0V$, $V_{GS}=\pm30V$			±100	nA		
ON CHARACTERISTICS								
Gate Threshold Voltage	V _{GS(TH)}	V _{DS} = V _{GS} , I _D =250µA			4.5	V		
Drain-Source On-State Resistance	R _{DS(ON)}	V _{GS} =10V, I _D =5.0A			0.35	Ω		
DYNAMIC PARAMETERS								
Input Capacitance	C _{ISS}			620		рF		
Output Capacitance	Coss	V _{GS} =0V, V _{DS} =25V, f=1.0MHz		480		рF		
Reverse Transfer Capacitance	C _{RSS}			56		pF		
SWITCHING PARAMETERS								
Total Gate Charge (Note 1)	Q_{G}	−V _{DS} =50V, V _{GS} =10V, I _D =1.3A , − −I _G =100µA (Note 1, 2)		42		nC		
Gate to Source Charge	Q_{GS}			4		nC		
Gate to Drain Charge	Q_{GD}			17.5		nC		
Turn-ON Delay Time (Note 1)	t _{D(ON)}	V _{DD} =30V, V _{GS} =10V, I _D =0.5A, R _G =25Ω (Note 1, 2)		60		ns		
Rise Time	t _R			103		ns		
Turn-OFF Delay Time	t _{D(OFF)}			152		ns		
Fall-Time	t⊨			112		ns		
SOURCE- DRAIN DIODE RATINGS AND CH	ARACTERIS	TICS		_	_			
Maximum Body-Diode Continuous Current	ls				10	Α		
Maximum Body-Diode Pulsed Current	I _{SM}				40	Α		
Drain-Source Diode Forward Voltage (Note 1)	V_{SD}	I _S =10A, V _{GS} =0V			1.4	V		
Body Diode Reverse Recovery Time (Note 1)	trr	I _S =10A, V _{GS} =0V,		310		ns		
Body Diode Reverse Recovery Charge	Qrr	dI _F /dt=100A/µs		3.8		μC		
Notes: 1. Pulse Test : Pulse width < 200 p. Duty evelor < 2%								

Notes: 1. Pulse Test : Pulse width \leq 300µs, Duty cycle \leq 2%.

2. Essentially independent of operating temperature.

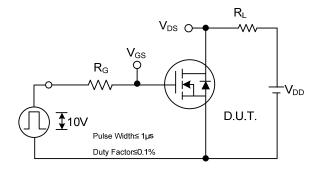


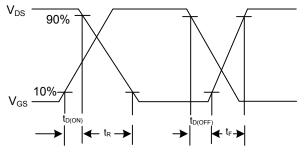
■ TEST CIRCUITS AND WAVEFORMS



10NM50

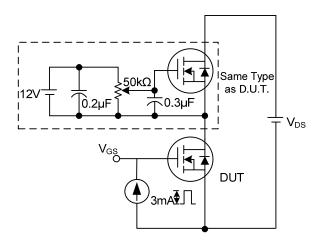
TEST CIRCUITS AND WAVEFORMS (Cont.)



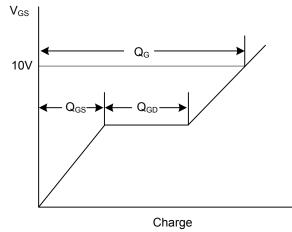


Switching Test Circuit

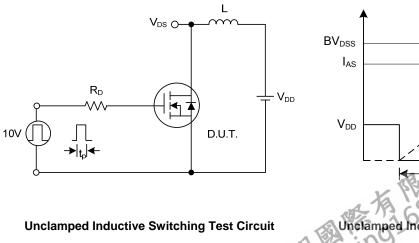


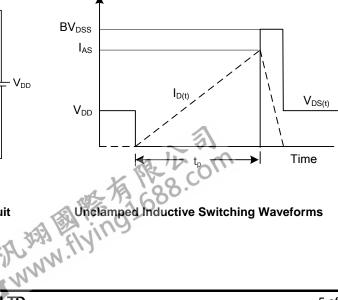


Gate Charge Test Circuit



Gate Charge Waveform









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